10NM70-FD2 Power MOSFET

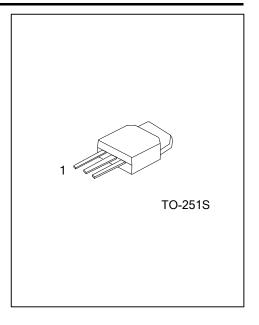
10A, 700V N-CHANNEL SUPER-JUNCTION MOSFET

■ DESCRIPTION

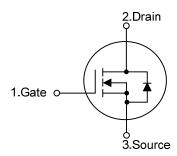
The **UTC 10NM70-FD2** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

■ FEATURES

- * $R_{DS(ON)}$ < 0.73 Ω @ V_{GS} =10V, I_{D} =5.0A
- * By using Super Junction Structure
- * Fast Switching
- * With 100% Avalanche Tested



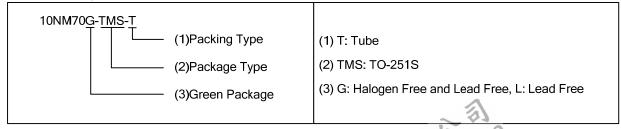
■ SYMBOL



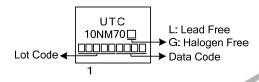
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
10NM70L-TMS-T	10NM70G-TMS-T	TO-251S	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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10NM70-FD2 **Power MOSFET**

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain to Source Voltage		V_{DSS}	700	V	
Gate to Source Voltage		V_{GSS}	±30	V	
Continuous Drain Current	Continuous	I_{D}	10	Α	
Pulsed Drain Current	Pulsed (Note 2)	I_{DM}	40	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	256	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	9	V/ns	
Power Dissipation		P_{D}	75	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T_{STG}	-55 ~ + 150	°C	

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
 - 3. L=150mH, I_{AS} =1.85A, V_{DD} = 50V, R_{G} =25 Ω , Starting T_{J} =25 $^{\circ}$ C.
 - 4. $I_{SD} \le 10A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C.

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θ_{JC}	1.67	°C/W	

ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

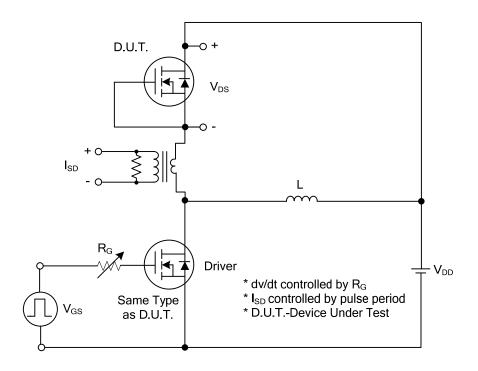
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} =0V, I_D =250 μ A	700			V	
Drain-Source Leakage Current	I _{DSS}	V _{DS} =700V, V _{GS} =0V			10	μΑ	
Gate-Source Leakage Current	I_{GSS}	V_{DS} =0V , V_{GS} =±30V			±100	nA	
ON CHARACTERISTICS							
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$			4.5	V	
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =5.0A			0.73	Ω	
DYNAMIC PARAMETERS							
Input Capacitance	C_{ISS}			587		pF	
Output Capacitance	Coss	V_{DS} =25V, V_{GS} =0V, f=1.0MHz		423		pF	
Reverse Transfer Capacitance	C_{RSS}			47		pF	
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)	Q_G	\/ -400\/ \/ -40\/		32.5		nC	
Gate to Source Charge	Q_GS	V _{DS} =400V, V _{GS} =10V, I _D =10A , I _G =10mA (Note 1, 2)		11.5		nC	
Gate to Drain Charge	Q_GD	ID-TOA, IG-TOTIA (Note 1, 2)		12.5		nC	
Turn-ON Delay Time (Note 1)	$t_{D(ON)}$			10		ns	
Rise Time	t_R	V _{DD} =350V, V _{GS} =10V,		25		ns	
Turn-OFF Delay Time	t _{D(OFF)}	I_D =10A, R_G =25 Ω (Note 1, 2)		65		ns	
Fall-Time	t_{F}			36		ns	
SOURCE- DRAIN DIODE RATINGS AND CHA	ARACTERIS	TICS					
Maximum Body-Diode Continuous Current	Is	~ 3			10	Α	
Maximum Body-Diode Pulsed Current	I _{SM}	10. 1	4		40	Α	
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	I _S =10A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time (Note 1)	t _{rr}	I _S =10A, V _{GS} =0V		300		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	df _F /dt=100A/µs		2		μC	

Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%

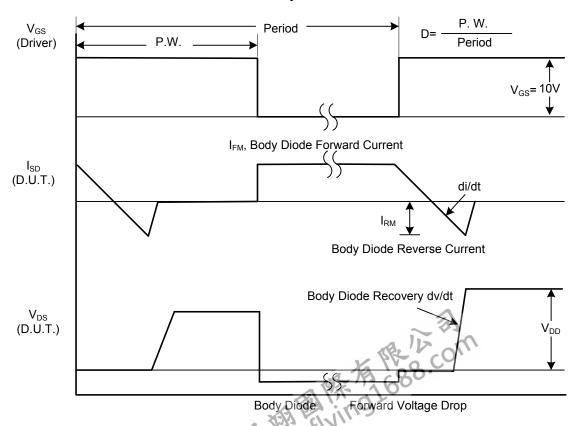
2. Essentially independent of operating temperature

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■ TEST CIRCUITS AND WAVEFORMS



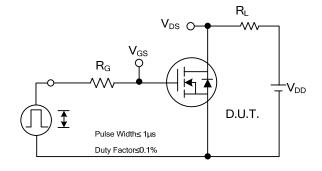
Peak Diode Recovery dv/dt Test Circuit

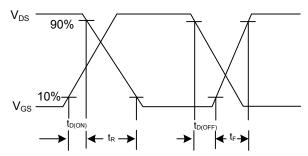


Peak Diode Recovery dv/dt Waveforms

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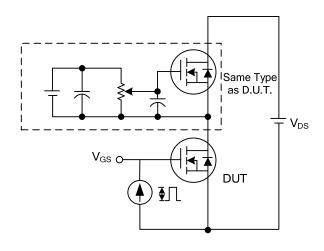
TEST CIRCUITS AND WAVEFORMS (Cont.)

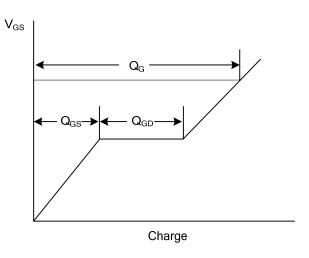




Switching Test Circuit

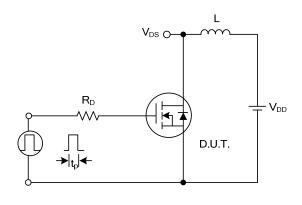
Switching Waveforms

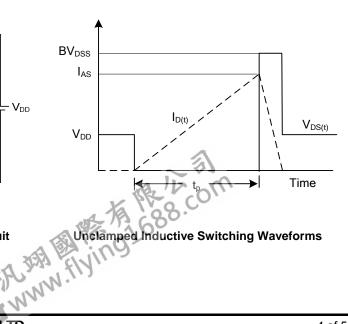




Gate Charge Test Circuit

Gate Charge Waveform

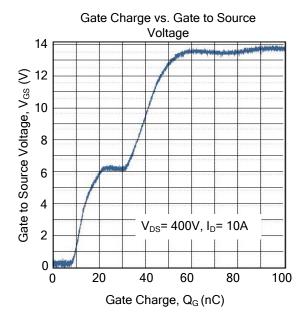


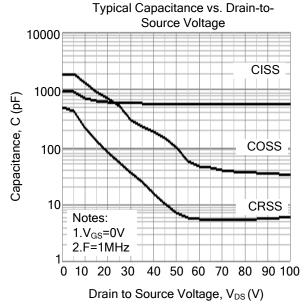


Unclamped Inductive Switching Test Circuit

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■ TYPICAL CHARACTERISTICS





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